Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination SHIN-ICHIROU HARASAWA	
10/056,080		
Examiner	Art Unit	
France te Dalzid Singh	2633	

SEARCHED			
Class	Subclass	Oate	Examiner
398	6,11,18	2/11/2005	TQL
•	23,32,33	2/11/2005	TQL
•	37,38,62	2/11/2005	TQL
*	64,97,157	2/11/2005	TQL
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH		)
	CATE	EXMR
Jason C.	2/11/2005	TQL
Inventor check	2/11/2005	TQL
EAST (US-PEPUB; USPAT; EPO; TPO) See Search Results Printout	8/4/05	ðs
EAST (US-PGPUB; USPAT; EPO; JPO)	11/38/65	Þs
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